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### **Understanding Embedded - FPGAs (Field Programmable Gate Array)**

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

### **Applications of Embedded - FPGAs**

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications,

#### **Details**

Product Status	Obsolete
Number of LABs/CLBs	-
Number of Logic Elements/Cells	-
Total RAM Bits	36864
Number of I/O	87
Number of Gates	250000
Voltage - Supply	1.425V ~ 1.575V
Mounting Type	Surface Mount
Operating Temperature	-40°C ~ 125°C (TA)
Package / Case	132-WFQFN
Supplier Device Package	132-QFN (8x8)
Purchase URL	<a href="https://www.e-xfl.com/product-detail/microsemi/a3p250-1qng132t">https://www.e-xfl.com/product-detail/microsemi/a3p250-1qng132t</a>

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# 1 – Military ProASIC3/EL Device Family Overview

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## General Description

The military ProASIC3/EL family of flash FPGAs dramatically reduces dynamic power consumption by 40% and static power by 50%. These power savings are coupled with performance, density, true single chip, 1.2 V to 1.5 V core and I/O operation, reprogrammability, and advanced features.

Microsemi's proven Flash\*Freeze technology enables military ProASIC3EL device users to shut off dynamic power instantaneously and switch the device to static mode without the need to switch off clocks or power supplies, and retaining internal states of the device. This greatly simplifies power management. In addition, optimized software tools using power-driven layout provide instant push-button power reduction.

Nonvolatile flash technology gives military ProASIC3/EL devices the advantage of being a secure, low-power, single-chip solution that is live at power-up (LAPU). Military ProASIC3/EL devices offer dramatic dynamic power savings, giving FPGA users flexibility to combine low power with high performance.

These features enable designers to create high-density systems using existing ASIC or FPGA design flows and tools.

Military ProASIC3/EL devices offer 1 kbit of on-chip, reprogrammable, nonvolatile FlashROM storage as well as clock conditioning circuitry (CCC) based on an integrated phase-locked loop (PLL). Military ProASIC3/EL devices support devices from 250K system gates to 3 million system gates with up to 504 kbits of true dual-port SRAM and 620 user I/Os.

M1 military ProASIC3/EL devices support the high-performance, 32-bit Cortex-M1 processor developed by ARM for implementation in FPGAs. ARM Cortex-M1 is a soft processor that is fully implemented in the FPGA fabric. It has a three-stage pipeline that offers a good balance between low-power consumption and speed when implemented in an M1 military ProASIC3/EL device. The processor runs the ARMv6-M instruction set, has a configurable nested interrupt controller, and can be implemented with or without the debug block. ARM Cortex-M1 is available at no cost from Microsemi for use in M1 military ProASIC3/EL FPGAs.

The ARM-enabled devices have ordering numbers that begin with M1 and do not support AES decryption.

## Flash\*Freeze Technology<sup>†</sup>

Military ProASIC3EL devices offer Flash\*Freeze technology, which allows instantaneous switching from an active state to a static state. When Flash\*Freeze mode is activated, military ProASIC3EL devices enter a static state while retaining the contents of registers and SRAM. Power is conserved without the need for additional external components to turn off I/Os or clocks. Flash\*Freeze technology is combined with in-system programmability, which enables users to quickly and easily upgrade and update their designs in the final stages of manufacturing or in the field. The ability of military ProASIC3EL devices to support a 1.2 V core voltage allows for an even greater reduction in power consumption, which enables low total system power.

When the military ProASIC3EL device enters Flash\*Freeze mode, the device automatically shuts off the clocks and inputs to the FPGA core; when the device exits Flash\*Freeze mode, all activity resumes and data is retained.

The availability of low-power modes, combined with a reprogrammable, single-chip, single-voltage solution, make military ProASIC3EL devices suitable for low-power data transfer and manipulation in military-temperature applications where available power may be limited (e.g., in battery-powered equipment); or where heat dissipation may be limited (e.g., in enclosures with no forced cooling).

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<sup>†</sup> Flash\*Freeze technology is not supported on A3P1000.

**Table 2-37 • I/O Output Buffer Maximum Resistances<sup>1</sup>**  
**Applicable to Advanced I/O Banks for A3P250 and A3P1000 Only**

Standard	Drive Strength	R <sub>PULL-DOWN</sub> (Ω) <sup>2</sup>	R <sub>PULL-UP</sub> (Ω) <sup>3</sup>
3.3 V LVTTL / 3.3 V LVCMOS	2 mA	100	300
	4 mA	100	300
	6 mA	50	150
	8 mA	50	150
	12 mA	25	75
	16 mA	17	50
	24 mA	11	33
3.3 V LVCMOS Wide Range	100 µA	Same as regular 3.3 V LVCMOS	
2.5 V LVCMOS	2 mA	100	300
	4 mA	100	300
	6 mA	50	150
	8 mA	50	150
	12 mA	25	75
	16 mA	17	50
	24 mA	11	33
1.8 V LVCMOS	2 mA	100	200
	4 mA	100	200
	6 mA	50	100
	8 mA	50	100
	12 mA	25	50
	16 mA	20	40
1.5 V LVCMOS	2 mA	200	224
	4 mA	100	112
	6 mA	67	75
	8 mA	33	37
	12 mA	33	37
3.3 V PCI/PCI-X	Per PCI/PCI-X specification	25	75

**Notes:**

1. These maximum values are provided for informational reasons only. Minimum output buffer resistance values depend on V<sub>CCl</sub>, drive strength selection, temperature, and process. For board design considerations and detailed output buffer resistances, use the corresponding IBIS models located at <http://www.microsemi.com/products/fpga-soc/design-resources/ibis-models>.
2. R<sub>(PULL-DOWN-MAX)</sub> = (V<sub>OLOspec</sub>) / I<sub>OLOspec</sub>
3. R<sub>(PULL-UP-MAX)</sub> = (V<sub>CClmax</sub> – V<sub>OHOspec</sub>) / I<sub>OHOspec</sub>

**Table 2-41 • I/O Short Currents IOSH/IOSL**  
**Applicable to Advanced I/O Banks for A3P250 and A3P1000 Only**

	Drive Strength	I <sub>OSL</sub> (mA)*	I <sub>OSH</sub> (mA)*
3.3 V LVTTL / 3.3V LVC MOS	2 mA	25	27
	4 mA	25	27
	6 mA	51	54
	8 mA	51	54
	12 mA	103	109
	16 mA	132	127
	24 mA	268	181
3.3 V LVC MOS Wide Range	100 µA	Same specification as regular LVC MOS 3.3 V	
2.5 V LVC MOS	2 mA	16	18
	4 mA	16	18
	6 mA	32	37
	8 mA	32	37
	12 mA	65	74
	16 mA	83	87
	24 mA	169	124
1.8 V LVC MOS	2 mA	9	11
	4 mA	17	22
	6 mA	35	44
	8 mA	45	51
	12 mA	91	74
	16 mA	91	74
1.5 V LVC MOS	2 mA	13	16
	4 mA	25	33
	6 mA	32	39
	8 mA	66	55
	12 mA	66	55
3.3 V PCI/PCI-X	Per PCI/PCI-X specification	103	109

*Note:* \* $T_J = 100^\circ\text{C}$

### **Timing Characteristics**

#### **1.2 V DC Core Voltage**

**Table 2-108 • 1.2 V LVC MOS Low Slew**

Military-Case Conditions:  $T_J = 125^\circ\text{C}$ , Worst-Case VCC = 1.14 V, Worst-Case VCCI = 1.4 V

Applicable to Pro I/O Banks for A3PE600L and A3PE3000L Only

Drive Strength	Speed Grade	$t_{DOUT}$	$t_{DP}$	$t_{DIN}$	$t_{PY}$	$t_{PYS}$	$t_{EOUT}$	$t_{ZL}$	$t_{ZH}$	$t_{LZ}$	$t_{HZ}$	$t_{ZLS}$	$t_{ZHS}$	Units
2 mA	Std.	0.80	12.61	0.05	2.65	3.75	0.52	12.10	9.50	5.11	4.66	14.31	11.71	ns
	-1	0.68	10.72	0.05	2.25	3.19	0.44	10.30	8.08	4.35	3.97	12.17	9.96	ns

*Note:* For specific junction temperature and voltage supply levels, refer to [Table 2-6 on page 2-6](#) for derating values.

**Table 2-109 • 1.2 V LVC MOS High Slew**

Military-Case Conditions:  $T_J = 125^\circ\text{C}$ , Worst-Case VCC = 1.14 V, Worst-Case VCCI = 1.4 V

Applicable to Pro I/O Banks for A3PE600L and A3PE3000L Only

Drive Strength	Speed Grade	$t_{DOUT}$	$t_{DP}$	$t_{DIN}$	$t_{PY}$	$t_{PYS}$	$t_{EOUT}$	$t_{ZL}$	$t_{ZH}$	$t_{LZ}$	$t_{HZ}$	$t_{ZLS}$	$t_{ZHS}$	Units
2 mA	Std.	0.80	5.16	0.05	2.65	3.75	0.52	4.98	4.39	5.10	4.81	7.19	6.60	ns
	-1	0.68	4.39	0.05	2.25	3.19	0.44	4.24	3.74	4.34	4.09	6.11	5.61	ns

*Notes:*

1. Software default selection highlighted in gray.
2. For specific junction temperature and voltage supply levels, refer to [Table 2-6 on page 2-6](#) for derating values.

### Timing Characteristics

#### 1.2 V DC Core Voltage

**Table 2-116 • 3.3 V PCI/PCI-X**

Military-Case Conditions:  $T_J = 125^\circ\text{C}$ , Worst-Case VCC = 1.14 V, Worst-Case VCCI = 3.0 V  
 Applicable to Pro I/Os for A3PE600L and A3PE3000L Only

Speed Grade	$t_{DOUT}$	$t_{DP}$	$t_{DIN}$	$t_{PY}$	$t_{PYS}$	$t_{EOUT}$	$t_{ZL}$	$t_{ZH}$	$t_{LZ}$	$t_{HZ}$	$t_{ZLS}$	$t_{ZHS}$	Units
Std.	0.80	2.78	0.05	2.71	3.68	0.52	2.83	1.97	3.26	3.59	5.03	4.18	ns
-1	0.68	2.37	0.05	2.31	3.13	0.44	2.40	1.68	2.77	3.06	4.28	3.56	ns

*Note:* For specific junction temperature and voltage supply levels, refer to [Table 2-6 on page 2-6](#) for derating values.

#### 1.5 V DC Core Voltage

**Table 2-117 • 3.3 V PCI/PCI-X**

Military-Case Conditions:  $T_J = 125^\circ\text{C}$ , VCC = 1.425 V, Worst-Case VCCI = 3.0 V  
 Applicable to Pro I/Os for A3PE600L and A3PE3000L Only

Speed Grade	$t_{DOUT}$	$t_{DP}$	$t_{DIN}$	$t_{PY}$	$t_{PYS}$	$t_{EOUT}$	$t_{ZL}$	$t_{ZH}$	$t_{LZ}$	$t_{HZ}$	$t_{ZLS}$	$t_{ZHS}$	Units
Std.	0.61	2.65	0.04	2.39	3.38	0.40	2.67	1.86	3.10	3.40	4.14	3.33	ns
-1	0.52	2.25	0.03	2.03	2.88	0.34	2.27	1.58	2.64	2.89	3.52	2.83	ns

*Note:* For specific junction temperature and voltage supply levels, refer to [Table 2-6 on page 2-6](#) for derating values.

**Table 2-118 • 3.3 V PCI/PCI-X**

Military-Case Conditions:  $T_J = 125^\circ\text{C}$ , Worst-Case VCC = 1.425 V, Worst-Case VCCI = 3.0 V  
 Applicable to Advanced I/O Banks

Speed Grade	$t_{DOUT}$	$t_{DP}$	$t_{DIN}$	$t_{PY}$	$t_{EOUT}$	$t_{ZL}$	$t_{ZH}$	$t_{LZ}$	$t_{HZ}$	$t_{ZLS}$	$t_{ZHS}$	Units
Std.	0.63	2.95	0.05	0.95	0.45	3.00	2.15	3.53	3.94	5.46	4.61	ns
-1	0.54	2.51	0.04	0.81	0.39	2.55	1.83	3.00	3.35	4.65	3.92	ns

*Note:* For specific junction temperature and voltage supply levels, refer to [Table 2-7 on page 2-6](#) for derating values.

**Table 2-119 • 3.3 V PCI/PCI-X**

Military-Case Conditions:  $T_J = 125^\circ\text{C}$ , Worst-Case VCC = 1.425 V, Worst-Case VCCI = 3.0 V  
 Applicable to Standard Plus I/O Banks

Speed Grade	$t_{DOUT}$	$t_{DP}$	$t_{DIN}$	$t_{PY}$	$t_{EOUT}$	$t_{ZL}$	$t_{ZH}$	$t_{LZ}$	$t_{HZ}$	$t_{ZLS}$	$t_{ZHS}$	Units
Std.	0.63	2.54	0.05	0.94	0.45	2.59	1.87	3.07	3.54	5.04	4.33	ns
-1	0.54	2.16	0.04	0.80	0.39	2.20	1.60	2.61	3.01	4.29	3.69	ns

*Note:* For specific junction temperature and voltage supply levels, refer to [Table 2-7 on page 2-6](#) for derating values.

**Table 2-123 • 3.3 V GTL**

 Military-Case Conditions:  $T_J = 125^\circ\text{C}$ ,  $V_{CC} = 1.425 \text{ V}$ ,

 Worst-Case  $V_{CCI} = 3.0 \text{ V}$ ,  $V_{REF} = 0.8 \text{ V}$ 

Applicable to Pro I/Os for A3PE600L and A3PE3000L Only

Speed Grade	$t_{DOUT}$	$t_{DP}$	$t_{DIN}$	$t_{PY}$	$t_{EOUT}$	$t_{ZL}$	$t_{ZH}$	$t_{LZ}$	$t_{HZ}$	$t_{ZLS}$	$t_{ZHS}$	Units
Std.	0.61	1.97	0.04	2.11	0.40	1.86	1.97	—	—	3.32	3.43	ns
-1	0.52	1.68	0.03	1.79	0.34	1.58	1.68	—	—	2.83	2.92	ns

*Note:* For specific junction temperature and voltage supply levels, refer to [Table 2-6 on page 2-6](#) for derating values.

## 2.5 V GTL+

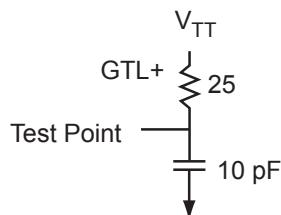
Gunning Transceiver Logic Plus is a high-speed bus standard (JESD8-3). It provides a differential amplifier input buffer and an open-drain output buffer. The V<sub>CCI</sub> pin should be connected to 2.5 V.

**Table 2-132 • Minimum and Maximum DC Input and Output Levels**

2.5 V GTL+	VIL		VIH		VOL	VOH	I <sub>OL</sub>	I <sub>OH</sub>	I <sub>OSL</sub>	I <sub>OSH</sub>	I <sub>IL</sub> <sup>1</sup>	I <sub>IH</sub> <sup>2</sup>
Drive Strength	Min. V	Max. V	Min. V	Max. V	Max. V	Min. V	mA	mA	Max. mA <sup>3</sup>	Max. mA <sup>3</sup>	μA <sup>4</sup>	μA <sup>4</sup>
33 mA	-0.3	VREF - 0.1	VREF + 0.1	3.6	0.6	-	33	33	169	124	15	15

*Notes:*

1.  $I_{IL}$  is the input leakage current per I/O pin over recommended operating conditions where  $-0.3 \text{ V} < \text{VIN} < \text{VIL}$ .
2.  $I_{IH}$  is the input leakage current per I/O pin over recommended operating conditions  $\text{VIH} < \text{VIN} < \text{VCCI}$ . Input current is larger when operating outside recommended ranges.
3. Currents are measured at 100°C junction temperature and maximum voltage.
4. Currents are measured at 125°C junction temperature.



**Figure 2-18 • AC Loading**

**Table 2-133 • AC Waveforms, Measuring Points, and Capacitive Loads**

Input Low (V)	Input High (V)	Measuring Point* (V)	VREF (typ.) (V)	VTT (typ.) (V)	C <sub>LOAD</sub> (pF)
VREF - 0.1	VREF + 0.1	1.0	1.0	1.5	10

*Note:* \*Measuring point =  $V_{trip}$ . See Table 2-29 on page 2-25 for a complete table of trip points.

## Timing Characteristics

**Table 2-134 • 2.5 V GTL+**

Military-Case Conditions:  $T_J = 125^\circ\text{C}$ , Worst-Case VCC = 1.14 V,

Worst-Case VCCI = 2.3 V, VREF = 1.0 V

Applicable to Pro I/Os for A3PE600L and A3PE3000L Only

Speed Grade	t <sub>DOUT</sub>	t <sub>DP</sub>	t <sub>DIN</sub>	t <sub>PY</sub>	t <sub>EOUT</sub>	t <sub>ZL</sub>	t <sub>ZH</sub>	t <sub>LZ</sub>	t <sub>HZ</sub>	t <sub>ZLS</sub>	t <sub>ZHS</sub>	Units
Std.	0.80	2.19	0.05	2.27	0.52	2.22	2.08	—	—	4.43	4.28	ns
-1	0.68	1.86	0.05	1.93	0.44	1.89	1.77	—	—	3.77	3.64	ns

*Note:* For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 for derating values.

**Table 2-135 • 2.5 V GTL+**

Military-Case Conditions:  $T_J = 125^\circ\text{C}$ , VCC = 1.425 V,

Worst-Case VCCI = 2.3 V, VREF = 1.0 V

Applicable to Pro I/Os for A3PE600L and A3PE3000L Only

Speed Grade	t <sub>DOUT</sub>	t <sub>DP</sub>	t <sub>DIN</sub>	t <sub>PY</sub>	t <sub>EOUT</sub>	t <sub>ZL</sub>	t <sub>ZH</sub>	t <sub>LZ</sub>	t <sub>HZ</sub>	t <sub>ZLS</sub>	t <sub>ZHS</sub>	Units
Std.	0.61	2.05	0.04	2.04	0.40	2.07	1.99	—	—	3.53	3.46	ns
-1	0.52	1.75	0.03	1.73	0.34	1.76	1.69	—	—	3.00	2.94	ns

*Note:* For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 for derating values.

**Table 2-139 • HSTL Class I**Military-Case Conditions:  $T_J = 125^\circ\text{C}$ ,  $VCC = 1.425 \text{ V}$ ,Worst-Case  $VCCI = 1.4 \text{ V}$ ,  $VREF = 0.75 \text{ V}$ 

Applicable to Pro I/Os for A3PE600L and A3PE3000L Only

Speed Grade	$t_{DOUT}$	$t_{DP}$	$t_{DIN}$	$t_{PY}$	$t_{EOUT}$	$t_{ZL}$	$t_{ZH}$	$t_{LZ}$	$t_{HZ}$	$t_{ZLS}$	$t_{ZHS}$	Units
Std.	0.61	3.02	0.04	2.52	0.40	3.05	3.00	—	—	4.51	4.46	ns
-1	0.52	2.57	0.03	2.14	0.34	2.59	2.55	—	—	3.84	3.79	ns

*Note:* For specific junction temperature and voltage supply levels, refer to [Table 2-6 on page 2-6](#) for derating values.

## I/O Register Specifications

### Fully Registered I/O Buffers with Synchronous Enable and Asynchronous Preset

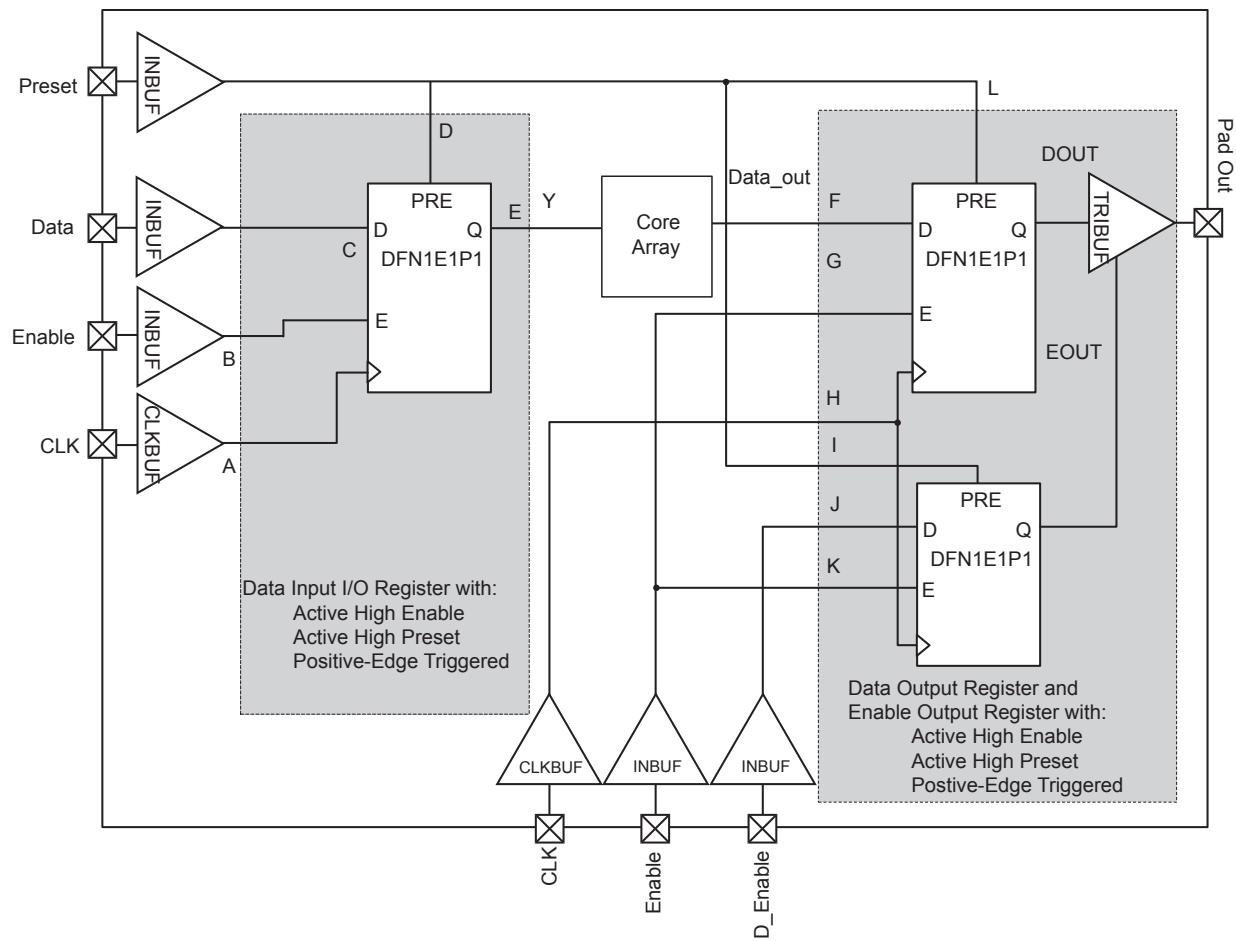
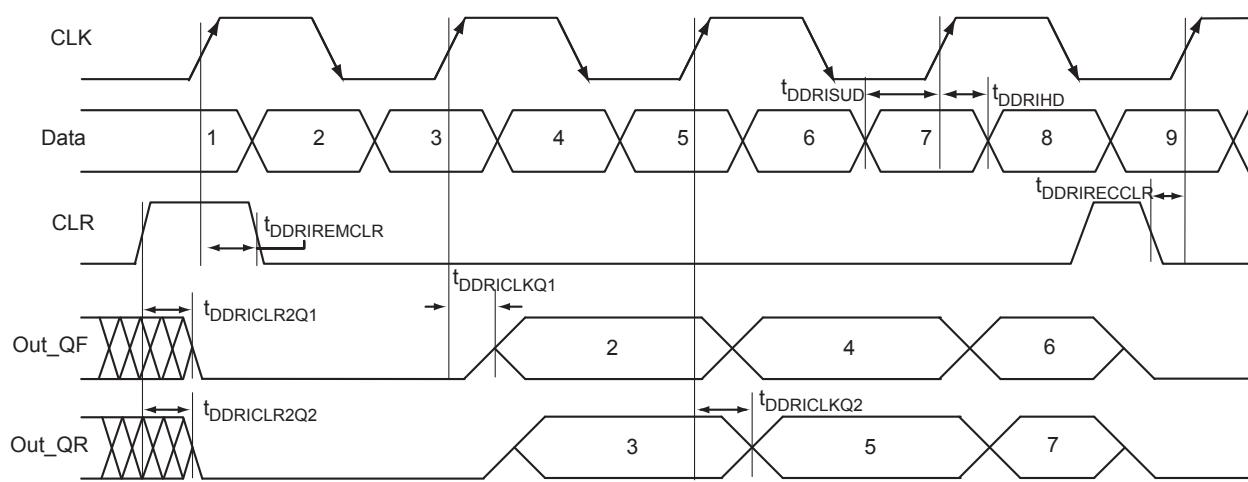


Figure 2-28 • Timing Model of Registered I/O Buffers with Synchronous Enable and Asynchronous Preset

**Table 2-171 • Parameter Definition and Measuring Nodes**

Parameter Name	Parameter Definition	Measuring Nodes (from, to)*
$t_{OCLKQ}$	Clock-to-Q of the Output Data Register	HH, DOUT
$t_{OSUD}$	Data Setup Time for the Output Data Register	FF, HH
$t_{OHD}$	Data Hold Time for the Output Data Register	FF, HH
$t_{OSUE}$	Enable Setup Time for the Output Data Register	GG, HH
$t_{OHE}$	Enable Hold Time for the Output Data Register	GG, HH
$t_{OCLR2Q}$	Asynchronous Clear-to-Q of the Output Data Register	LL, DOUT
$t_{OREMCLR}$	Asynchronous Clear Removal Time for the Output Data Register	LL, HH
$t_{ORECCLR}$	Asynchronous Clear Recovery Time for the Output Data Register	LL, HH
$t_{OECLKQ}$	Clock-to-Q of the Output Enable Register	HH, EOUT
$t_{OESUD}$	Data Setup Time for the Output Enable Register	JJ, HH
$t_{OEHD}$	Data Hold Time for the Output Enable Register	JJ, HH
$t_{OESUE}$	Enable Setup Time for the Output Enable Register	KK, HH
$t_{OEHE}$	Enable Hold Time for the Output Enable Register	KK, HH
$t_{OECLR2Q}$	Asynchronous Clear-to-Q of the Output Enable Register	II, EOUT
$t_{OEREMCLR}$	Asynchronous Clear Removal Time for the Output Enable Register	II, HH
$t_{OERECCCLR}$	Asynchronous Clear Recovery Time for the Output Enable Register	II, HH
$t_{ICLKQ}$	Clock-to-Q of the Input Data Register	AA, EE
$t_{ISUD}$	Data Setup Time for the Input Data Register	CC, AA
$t_{IHD}$	Data Hold Time for the Input Data Register	CC, AA
$t_{ISUE}$	Enable Setup Time for the Input Data Register	BB, AA
$t_{IHE}$	Enable Hold Time for the Input Data Register	BB, AA
$t_{ICLR2Q}$	Asynchronous Clear-to-Q of the Input Data Register	DD, EE
$t_{IREMCLR}$	Asynchronous Clear Removal Time for the Input Data Register	DD, AA
$t_{IRECCLR}$	Asynchronous Clear Recovery Time for the Input Data Register	DD, AA

\* See [Figure 2-29 on page 2-93](#) for more information.



**Figure 2-34 • Input DDR Timing Diagram**

### Timing Characteristics

**Table 2-182 • Input DDR Propagation Delays**

Military-Case Conditions:  $T_J = 125^{\circ}\text{C}$ , Worst-Case  $V_{CC} = 1.14\text{ V}$  for A3PE600L and A3PE3000L

Parameter	Description	-1	Std.	Units
$t_{DDRICLKQ1}$	Clock-to-Out Out_QR for Input DDR	0.38	0.45	ns
$t_{DDRICLKQ2}$	Clock-to-Out Out_QF for Input DDR	0.54	0.63	ns
$t_{DDRISUD1}$	Data Setup for Input DDR (fall)	0.39	0.46	ns
$t_{DDRISUD2}$	Data Setup for Input DDR (rise)	0.34	0.40	ns
$t_{DDRIHD1}$	Data Hold for Input DDR (fall)	0.00	0.00	ns
$t_{DDRIHD2}$	Data Hold for Input DDR (rise)	0.00	0.00	ns
$t_{DDRICL2Q1}$	Asynchronous Clear-to-Out Out_QR for Input DDR	0.64	0.75	ns
$t_{DDRICL2Q2}$	Asynchronous Clear-to-Out Out_QF for Input DDR	0.79	0.93	ns
$t_{DDRIREMCLR}$	Asynchronous Clear Removal Time for Input DDR	0.00	0.00	ns
$t_{DDRIRECCCLR}$	Asynchronous Clear Recovery Time for Input DDR	0.31	0.36	ns
$t_{DDRIWCLR}$	Asynchronous Clear Minimum Pulse Width for Input DDR	0.19	0.22	ns
$t_{DDRICKMPWH}$	Clock Minimum Pulse Width HIGH for Input DDR	0.31	0.36	ns
$t_{DDRICKMPWL}$	Clock Minimum Pulse Width LOW for Input DDR	0.28	0.32	ns
$F_{DDRIMAX}$	Maximum Frequency for Input DDR	160	160	MHz

*Note:* For specific junction temperature and voltage supply levels, refer to Table 2-6 on page 2-6 for derating values.

**Table 2-183 • Input DDR Propagation Delays**Military-Case Conditions:  $T_J = 125^\circ\text{C}$ ,  $VCC = 1.425 \text{ V}$  for any A3PE600L/A3PE3000L

Parameter	Description	-1	Std.	Units
$t_{DDRICLKQ1}$	Clock-to-Out Out_QR for Input DDR	0.29	0.34	ns
$t_{DDRICLKQ2}$	Clock-to-Out Out_QF for Input DDR	0.41	0.48	ns
$t_{DDRISUD1}$	Data Setup for Input DDR (fall)	0.30	0.35	ns
$t_{DDRISUD2}$	Data Setup for Input DDR (rise)	0.26	0.31	ns
$t_{DDRIHD1}$	Data Hold for Input DDR (fall)	0.00	0.00	ns
$t_{DDRIHD2}$	Data Hold for Input DDR (rise)	0.00	0.00	ns
$t_{DDRICLR2Q1}$	Asynchronous Clear-to-Out Out_QR for Input DDR	0.49	0.58	ns
$t_{DDRICLR2Q2}$	Asynchronous Clear-to-Out Out_QF for Input DDR	0.60	0.71	ns
$t_{DDIREMCLR}$	Asynchronous Clear Removal Time for Input DDR	0.00	0.00	ns
$t_{DDIRECCLR}$	Asynchronous Clear Recovery Time for Input DDR	0.24	0.28	ns
$t_{DDRIWCLR}$	Asynchronous Clear Minimum Pulse Width for Input DDR	0.19	0.22	ns
$t_{DDRICKMPWH}$	Clock Minimum Pulse Width HIGH for Input DDR	0.31	0.36	ns
$t_{DDRICKMPWL}$	Clock Minimum Pulse Width LOW for Input DDR	0.28	0.32	ns
$F_{DDRIMAX}$	Maximum Frequency for Input DDR	250	250	MHz

*Note:* For specific junction temperature and voltage supply levels, refer to [Table 2-6 on page 2-6](#) for derating values.

**Table 2-184 • Input DDR Propagation Delays**Military-Case Conditions:  $T_J = 125^\circ\text{C}$ , Worst-Case  $VCC = 1.425 \text{ V}$  for A3P250 and A3P1000

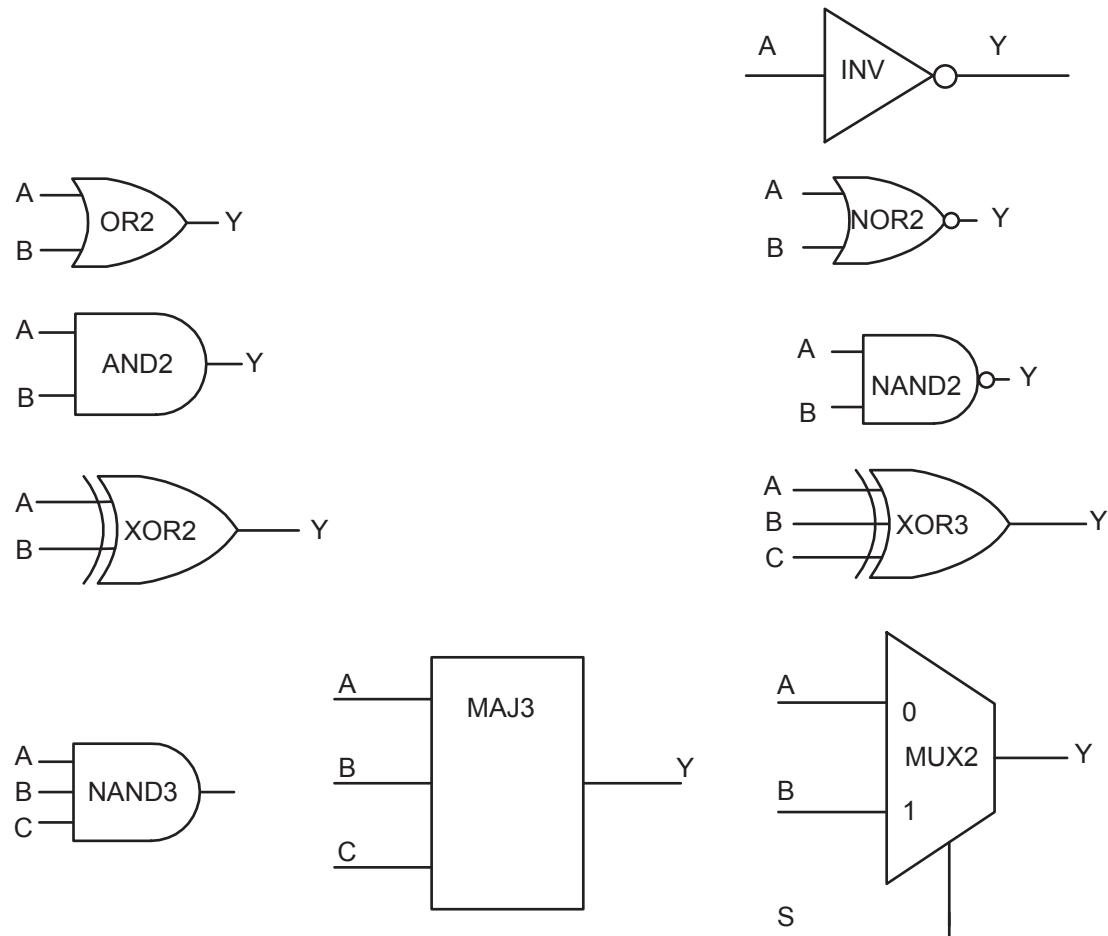
Parameter	Description	-1	Std.	Units
$t_{DDRICLKQ1}$	Clock-to-Out Out_QR for Input DDR	0.33	0.39	ns
$t_{DDRICLKQ2}$	Clock-to-Out Out_QF for Input DDR	0.47	0.55	ns
$t_{DDRISUD1}$	Data Setup for Input DDR (fall)	0.30	0.35	ns
$t_{DDRISUD2}$	Data Setup for Input DDR (rise)	0.30	0.35	ns
$t_{DDRIHD1}$	Data Hold for Input DDR (fall)	0.00	0.00	ns
$t_{DDRIHD2}$	Data Hold for Input DDR (rise)	0.00	0.00	ns
$t_{DDRICLR2Q1}$	Asynchronous Clear-to-Out Out_QR for Input DDR	0.56	0.65	ns
$t_{DDRICLR2Q2}$	Asynchronous Clear-to-Out Out_QF for Input DDR	0.69	0.81	ns
$t_{DDIREMCLR}$	Asynchronous Clear Removal Time for Input DDR	0.00	0.00	ns
$t_{DDIRECCLR}$	Asynchronous Clear Recovery Time for Input DDR	0.27	0.31	ns
$t_{DDRIWCLR}$	Asynchronous Clear Minimum Pulse Width for Input DDR	0.25	0.30	ns
$t_{DDRICKMPWH}$	Clock Minimum Pulse Width HIGH for Input DDR	0.41	0.48	ns
$t_{DDRICKMPWL}$	Clock Minimum Pulse Width LOW for Input DDR	0.37	0.43	ns
$F_{DDRIMAX}$	Maximum Frequency for Input DDR	309	263	MHz

*Note:* For specific junction temperature and voltage supply levels, refer to [Table 2-7 on page 2-6](#) for derating values.

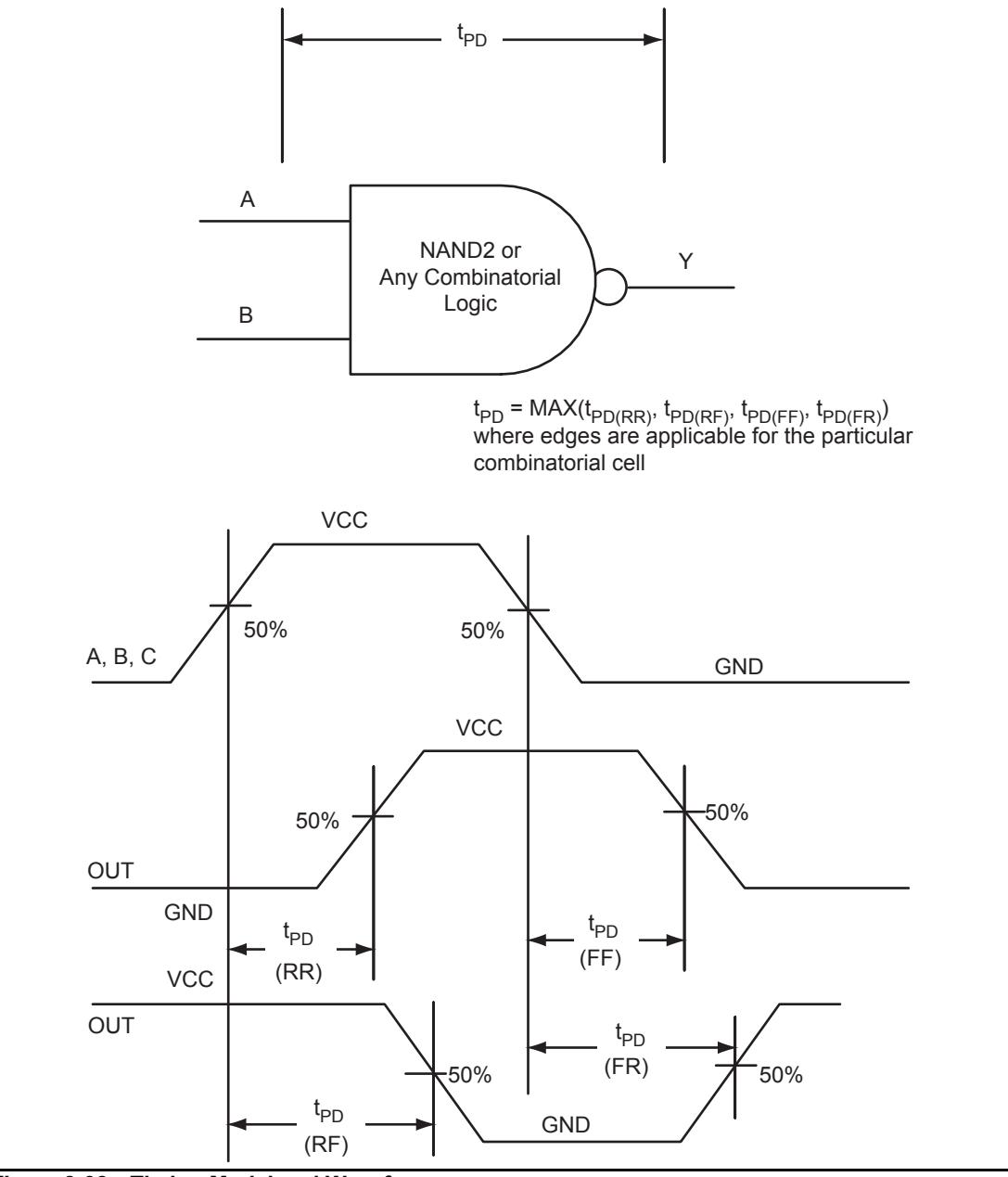
## VersaTile Characteristics

### VersaTile Specifications as a Combinatorial Module

The military ProASIC3 library offers all combinations of LUT-3 combinatorial functions. In this section, timing characteristics are presented for a sample of the library. For more details, refer to the [IGLOO, Fusion, and ProASIC3 Macro Library Guide](#).



**Figure 2-37 • Sample of Combinatorial Cells**



**Figure 2-38 • Timing Model and Waveforms**

## Timing Characteristics

**Table 2-189 • Combinatorial Cell Propagation Delays**

Military-Case Conditions:  $T_J = 125^\circ\text{C}$ , Worst-Case VCC = 1.14 V for A3PE600L and A3PE3000L

Combinatorial Cell	Equation	Parameter	-1	Std.	Units
INV	$Y = !A$	$t_{PD}$	0.56	0.65	ns
AND2	$Y = A \cdot B$	$t_{PD}$	0.65	0.77	ns
NAND2	$Y = !(A \cdot B)$	$t_{PD}$	0.65	0.77	ns
OR2	$Y = A + B$	$t_{PD}$	0.67	0.79	ns
NOR2	$Y = !(A + B)$	$t_{PD}$	0.67	0.79	ns
XOR2	$Y = A \oplus B$	$t_{PD}$	1.02	1.20	ns
MAJ3	$Y = MAJ(A, B, C)$	$t_{PD}$	0.97	1.14	ns
XOR3	$Y = A \oplus B \oplus C$	$t_{PD}$	1.21	1.42	ns
MUX2	$Y = A IS + B S$	$t_{PD}$	0.70	0.82	ns
AND3	$Y = A \cdot B \cdot C$	$t_{PD}$	0.78	0.91	ns

*Note:* For specific junction temperature and voltage supply levels, refer to [Table 2-6 on page 2-6](#) for derating values.

**Table 2-190 • Combinatorial Cell Propagation Delays**

Military-Case Conditions:  $T_J = 125^\circ\text{C}$ , VCC = 1.425 V for any A3PE600L/A3PE3000L

Combinatorial Cell	Equation	Parameter	-1	Std.	Units
INV	$Y = !A$	$t_{PD}$	0.43	0.50	ns
AND2	$Y = A \cdot B$	$t_{PD}$	0.50	0.59	ns
NAND2	$Y = !(A \cdot B)$	$t_{PD}$	0.50	0.59	ns
OR2	$Y = A + B$	$t_{PD}$	0.51	0.61	ns
NOR2	$Y = !(A + B)$	$t_{PD}$	0.51	0.61	ns
XOR2	$Y = A \oplus B$	$t_{PD}$	0.78	0.92	ns
MAJ3	$Y = MAJ(A, B, C)$	$t_{PD}$	0.74	0.87	ns
XOR3	$Y = A \oplus B \oplus C$	$t_{PD}$	0.93	1.09	ns
MUX2	$Y = A IS + B S$	$t_{PD}$	0.54	0.63	ns
AND3	$Y = A \cdot B \cdot C$	$t_{PD}$	0.59	0.70	ns

*Note:* For specific junction temperature and voltage supply levels, refer to [Table 2-6 on page 2-6](#) for derating values.

**Table 2-216 • FIFO Worst Military-Case Conditions:  $T_J = 125^\circ\text{C}$ ,  $VCC = 1.425 \text{ V}$  for A3P250 (4kx1)**

Parameter	Description	-1	Std.	Units
$t_{ENS}$	REN, WEN Setup Time	5.85	6.87	ns
$t_{ENH}$	REN, WEN Hold Time	0.00	0.00	ns
$t_{BKS}$	BLK Setup Time	1.66	1.95	ns
$t_{BKH}$	BLK Hold Time	0.00	0.00	ns
$t_{DS}$	Input Data (WD) Setup Time	0.22	0.26	ns
$t_{DH}$	Input Data (WD) Hold Time	0.00	0.00	ns
$t_{CKQ1}$	Clock HIGH to New Data Valid on RD (flow-through)	2.84	3.33	ns
$t_{CKQ2}$	Clock HIGH to New Data Valid on RD (pipelined)	1.08	1.27	ns
$t_{RCKEF}$	RCLK HIGH to Empty Flag Valid	2.07	2.43	ns
$t_{WCKFF}$	WCLK HIGH to Full Flag Valid	1.96	2.31	ns
$t_{CKAF}$	Clock HIGH to Almost Empty/Full Flag Valid	7.45	8.76	ns
$t_{RSTFG}$	RESET LOW to Empty/Full Flag Valid	2.04	2.40	ns
$t_{RSTAF}$	RESET LOW to Almost Empty/Full Flag Valid	7.38	8.67	ns
$t_{RSTBQ}$	RESET LOW to Data Out LOW on RD (flow-through)	1.11	1.31	ns
	RESET LOW to Data Out LOW on RD (pipelined)	1.11	1.31	ns
$t_{REMRSTB}$	RESET Removal	0.34	0.40	ns
$t_{RECRSTB}$	RESET Recovery	1.81	2.12	ns
$t_{MPWRSTB}$	RESET Minimum Pulse Width	0.26	0.30	ns
$t_{CYC}$	Clock Cycle Time	3.89	4.57	ns
$F_{MAX}$	Maximum Frequency for FIFO	257	219	MHz

*Note:* For specific junction temperature and voltage supply levels, refer to [Table 2-7 on page 2-6](#) for derating values.

<b>FG484</b>	
<b>Pin Number</b>	<b>A3PE600L Function</b>
A1	GND
A2	GND
A3	VCCIB0
A4	IO06NDB0V1
A5	IO06PDB0V1
A6	IO08NDB0V1
A7	IO08PDB0V1
A8	IO11PDB0V1
A9	IO17PDB0V2
A10	IO18NDB0V2
A11	IO18PDB0V2
A12	IO22PDB1V0
A13	IO26PDB1V0
A14	IO29NDB1V1
A15	IO29PDB1V1
A16	IO31NDB1V1
A17	IO31PDB1V1
A18	IO32NDB1V1
A19	NC
A20	VCCIB1
A21	GND
A22	GND
B1	GND
B2	VCCIB7
B3	NC
B4	IO03NDB0V0
B5	IO03PDB0V0
B6	IO07NDB0V1
B7	IO07PDB0V1
B8	IO11NDB0V1
B9	IO17NDB0V2
B10	IO14PDB0V2
B11	IO19PDB0V2
B12	IO22NDB1V0
B13	IO26NDB1V0

<b>FG484</b>	
<b>Pin Number</b>	<b>A3PE600L Function</b>
B14	NC
B15	NC
B16	IO30NDB1V1
B17	IO30PDB1V1
B18	IO32PDB1V1
B19	NC
B20	NC
B21	VCCIB2
B22	GND
C1	VCCIB7
C2	NC
C3	NC
C4	NC
C5	GND
C6	IO04NDB0V0
C7	IO04PDB0V0
C8	VCC
C9	VCC
C10	IO14NDB0V2
C11	IO19NDB0V2
C12	NC
C13	NC
C14	VCC
C15	VCC
C16	NC
C17	NC
C18	GND
C19	NC
C20	NC
C21	NC
C22	VCCIB2
D1	NC
D2	NC
D3	NC
D4	GND

<b>FG484</b>	
<b>Pin Number</b>	<b>A3PE600L Function</b>
D5	GAA0/IO00NDB0V0
D6	GAA1/IO00PDB0V0
D7	GAB0/IO01NDB0V0
D8	IO05PDB0V0
D9	IO10PDB0V1
D10	IO12PDB0V2
D11	IO16NDB0V2
D12	IO23NDB1V0
D13	IO23PDB1V0
D14	IO28NDB1V1
D15	IO28PDB1V1
D16	GBB1/IO34PDB1V1
D17	GBA0/IO35NDB1V1
D18	GBA1/IO35PDB1V1
D19	GND
D20	NC
D21	NC
D22	NC
E1	NC
E2	NC
E3	GND
E4	GAB2/IO133PDB7V1
E5	GAA2/IO134PDB7V1
E6	GNDQ
E7	GAB1/IO01PDB0V0
E8	IO05NDB0V0
E9	IO10NDB0V1
E10	IO12NDB0V2
E11	IO16PDB0V2
E12	IO20NDB1V0
E13	IO24NDB1V0
E14	IO24PDB1V0
E15	GBC1/IO33PDB1V1
E16	GBB0/IO34NDB1V1
E17	GNDQ

<b>FG484</b>	
<b>Pin Number</b>	<b>A3PE3000L Function</b>
C18	GND
C19	IO76PPB1V4
C20	IO88NDB2V0
C21	IO94PPB2V1
C22	VCCIB2
D1	IO293PDB7V2
D2	IO303NDB7V3
D3	IO305NDB7V3
D4	GND
D5	GAA0/IO00NDB0V0
D6	GAA1/IO00PDB0V0
D7	GAB0/IO01NDB0V0
D8	IO20PDB0V2
D9	IO22PDB0V2
D10	IO30PDB0V3
D11	IO38NDB0V4
D12	IO52NDB1V1
D13	IO52PDB1V1
D14	IO66NDB1V3
D15	IO66PDB1V3
D16	GBB1/IO80PDB1V4
D17	GBA0/IO81NDB1V4
D18	GBA1/IO81PDB1V4
D19	GND
D20	IO88PDB2V0
D21	IO90PDB2V1
D22	IO94NPB2V1
E1	IO293NDB7V2
E2	IO299PPB7V3
E3	GND
E4	GAB2/IO308PDB7V4
E5	GAA2/IO309PDB7V4
E6	GNDQ
E7	GAB1/IO01PDB0V0
E8	IO20NDB0V2

<b>FG484</b>	
<b>Pin Number</b>	<b>A3PE3000L Function</b>
E9	IO22NDB0V2
E10	IO30NDB0V3
E11	IO38PDB0V4
E12	IO44NDB1V0
E13	IO58NDB1V2
E14	IO58PDB1V2
E15	GBC1/IO79PDB1V4
E16	GBB0/IO80NDB1V4
E17	GNDQ
E18	GBA2/IO82PDB2V0
E19	IO86NDB2V0
E20	GND
E21	IO90NDB2V1
E22	IO98PDB2V2
F1	IO299NPB7V3
F2	IO301NDB7V3
F3	IO301PDB7V3
F4	IO308NDB7V4
F5	IO309NDB7V4
F6	VMV7
F7	VCCPLA
F8	GAC0/IO02NDB0V0
F9	GAC1/IO02PDB0V0
F10	IO32NDB0V3
F11	IO32PDB0V3
F12	IO44PDB1V0
F13	IO50NDB1V1
F14	IO60PDB1V2
F15	GBC0/IO79NDB1V4
F16	VCCPLB
F17	VMV2
F18	IO82NDB2V0
F19	IO86PDB2V0
F20	IO96PDB2V1
F21	IO96NDB2V1

<b>FG484</b>	
<b>Pin Number</b>	<b>A3PE3000L Function</b>
F22	IO98NDB2V2
G1	IO289NDB7V1
G2	IO289PDB7V1
G3	IO291PPB7V2
G4	IO295PDB7V2
G5	IO297PDB7V2
G6	GAC2/IO307PDB7V4
G7	VCOMPLA
G8	GNDQ
G9	IO26NDB0V3
G10	IO26PDB0V3
G11	IO36PDB0V4
G12	IO42PDB1V0
G13	IO50PDB1V1
G14	IO60NDB1V2
G15	GNDQ
G16	VCOMPLB
G17	GBB2/IO83PDB2V0
G18	IO92PDB2V1
G19	IO92NDB2V1
G20	IO102PDB2V2
G21	IO102NDB2V2
G22	IO105NDB2V2
H1	IO286PSB7V1
H2	IO291NPB7V2
H3	VCC
H4	IO295NDB7V2
H5	IO297NDB7V2
H6	IO307NDB7V4
H7	IO287PDB7V1
H8	VMV0
H9	VCCIB0
H10	VCCIB0
H11	IO36NDB0V4
H12	IO42NDB1V0

<b>FG484</b>	
<b>Pin Number</b>	<b>A3PE3000L Function</b>
H13	VCCIB1
H14	VCCIB1
H15	VMV1
H16	GBC2/IO84PDB2V0
H17	IO83NDB2V0
H18	IO100NDB2V2
H19	IO100PDB2V2
H20	VCC
H21	VMV2
H22	IO105PDB2V2
J1	IO285NDB7V1
J2	IO285PDB7V1
J3	VMV7
J4	IO279PDB7V0
J5	IO283PDB7V1
J6	IO281PDB7V0
J7	IO287NDB7V1
J8	VCCIB7
J9	GND
J10	VCC
J11	VCC
J12	VCC
J13	VCC
J14	GND
J15	VCCIB2
J16	IO84NDB2V0
J17	IO104NDB2V2
J18	IO104PDB2V2
J19	IO106PPB2V3
J20	GNDQ
J21	IO109PDB2V3
J22	IO107PDB2V3
K1	IO277NDB7V0
K2	IO277PDB7V0
K3	GNDQ

<b>FG484</b>	
<b>Pin Number</b>	<b>A3PE3000L Function</b>
K4	IO279NDB7V0
K5	IO283NDB7V1
K6	IO281NDB7V0
K7	GFC1/IO275PPB7V0
K8	VCCIB7
K9	VCC
K10	GND
K11	GND
K12	GND
K13	GND
K14	VCC
K15	VCCIB2
K16	GCC1/IO112PPB2V3
K17	IO108NDB2V3
K18	IO108PDB2V3
K19	IO110NPB2V3
K20	IO106NPB2V3
K21	IO109NDB2V3
K22	IO107NDB2V3
L1	IO257PSB6V2
L2	IO276PDB7V0
L3	IO276NDB7V0
L4	GFB0/IO274NPB7V0
L5	GFA0/IO273NDB6V4
L6	GFB1/IO274PPB7V0
L7	VCOMPLF
L8	GFC0/IO275NPB7V0
L9	VCC
L10	GND
L11	GND
L12	GND
L13	GND
L14	VCC
L15	GCC0/IO112NPB2V3
L16	GCB1/IO113PPB2V3

<b>FG484</b>	
<b>Pin Number</b>	<b>A3PE3000L Function</b>
L17	GCA0/IO114NPB3V0
L18	VCOMPLC
L19	GCB0/IO113NPB2V3
L20	IO110PPB2V3
L21	IO111NDB2V3
L22	IO111PDB2V3
M1	GNDQ
M2	IO255NPB6V2
M3	IO272NDB6V4
M4	GFA2/IO272PDB6V4
M5	GFA1/IO273PDB6V4
M6	VCCPLF
M7	IO271NDB6V4
M8	GFB2/IO271PDB6V4
M9	VCC
M10	GND
M11	GND
M12	GND
M13	GND
M14	VCC
M15	GCB2/IO116PPB3V0
M16	GCA1/IO114PPB3V0
M17	GCC2/IO117PPB3V0
M18	VCCPLC
M19	GCA2/IO115PDB3V0
M20	IO115NDB3V0
M21	IO126PDB3V1
M22	IO124PSB3V1
N1	IO255PPB6V2
N2	IO253NDB6V2
N3	VMV6
N4	GFC2/IO270PPB6V4
N5	IO261PPB6V3
N6	IO263PDB6V3
N7	IO263NDB6V3

Revision	Changes	Page
Revision 1 (continued)	<p>The drive strength was changed from 25 mA to 20 mA for 3.3 V and 2.5 V GTL (SAR 31978). This affects the following tables:</p> <p><a href="#">Table 2-25 • Summary of Maximum and Minimum DC Input and Output Levels</a>  <a href="#">Table 2-31 • Summary of I/O Timing Characteristics—Software Default Settings (SAR 32394)</a>  <a href="#">Table 2-32 • Summary of I/O Timing Characteristics—Software Default Settings</a>  <a href="#">Table 2-36 • I/O Output Buffer Maximum Resistances<sup>1</sup> Applicable to Pro I/Os for A3PE600L and A3PE3000L Only</a>  <a href="#">Table 2-40 • I/O Short Currents IOSH/IOSL Applicable to Pro I/Os for A3PE600L and A3PE3000L Only</a>  <a href="#">Table 2-120 • Minimum and Maximum DC Input and Output Levels</a>  <a href="#">Table 2-124 • Minimum and Maximum DC Input and Output Levels</a></p> <p>The values in <a href="#">Table 2-39 • I/O Weak Pull-Up/Pull-Down Resistances</a> were revised (SAR 29793, 28061).</p> <p>The AC Loading diagrams in the "Single-Ended I/O Characteristics" section were updated to match summary of I/O timing tables in the "Summary of I/O Timing Characteristics – Default I/O Software Settings" section (SAR 32449).</p> <p>The tables in the "Voltage-Referenced I/O Characteristics" section and "Differential I/O Characteristics" section were updated with current values (SARs 29793, 32391, 32394).</p> <p>Two note references were added to <a href="#">Table 2-160 • Minimum and Maximum DC Input and Output Levels</a> to clarify the following notes: ±5% [VCCI] and differential input voltage = ±350 mV [VDIFF] (SAR 29428).</p> <p>The "Global Tree Timing Characteristics" section was updated.</p> <p><a href="#">Table 2-199 • A3P250 Global Resource</a> is new (SAR 30526).</p> <p>Available values were added or revised in the following tables (SAR 30698):</p> <p><a href="#">Table 2-195 • A3PE600L Global Resource</a>  <a href="#">Table 2-200 • A3P1000 Global Resource</a>  <a href="#">Table 2-197 • A3PE600L Global Resource</a></p> <p><a href="#">Table 2-201 • Military ProASIC3/EL CCC/PLL Specification</a> and <a href="#">Table 2-202 • Military ProASIC3/EL CCC/PLL Specification</a> were updated with current values (SAR 32521).</p> <p>The following figures were removed (SAR 29991):</p> <p><a href="#">Figure 2-49 • Write Access after Write onto Same Address</a>  <a href="#">Figure 2-50 • Read Access after Write onto Same Address</a>  <a href="#">Figure 2-51 • Write Access after Read onto Same Address</a></p> <p>The naming of the address collision parameters in the SRAM "Timing Characteristics" section was changed, and values were updated accordingly (SAR 29991).</p> <p>The values for <math>t_{CKQ1}</math> in <a href="#">Table 2-203 • RAM4K9</a>, <a href="#">Table 2-204 • RAM4K9</a>, and <a href="#">Table 2-205 • RAM4K9</a> were reversed with respect to WMODE and have been corrected (SAR 32343).</p> <p><a href="#">Table 2-212 • FIFO</a> through <a href="#">Table 2-216 • FIFO</a> are new (SAR 32394).</p> <p>Tables in the "Embedded FlashROM Characteristics" section were updated (SAR 32392).</p> <p>The "Pin Descriptions and Packaging" chapter was added (SAR 21642).</p> <p>Package names used in the "Package Pin Assignments" section were revised to match standards given in <a href="#">Package Mechanical Drawings</a> (SAR 27395).</p>	<p><a href="#">2-22</a>  <a href="#">2-26</a>  <a href="#">2-27</a>  <a href="#">2-30</a>  <a href="#">2-33</a>  <a href="#">2-73</a>  <a href="#">2-75</a></p> <p><a href="#">2-32</a></p> <p><a href="#">2-37</a></p> <p><a href="#">2-73</a>  <a href="#">2-85</a></p> <p><a href="#">2-86</a></p> <p><a href="#">2-120</a></p> <p><a href="#">2-123</a></p> <p>N/A</p> <p><a href="#">2-129</a></p> <p><a href="#">2-129</a>,  <a href="#">2-130</a>,  <a href="#">2-131</a></p> <p><a href="#">2-141</a>,  <a href="#">2-145</a></p> <p><a href="#">2-146</a></p> <p><a href="#">3-1</a></p> <p><a href="#">4-1</a></p>